Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination BHAT ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0026708 A1	02-2004	Chen, Tzer-Perng	257/99
	В	US-2003/0222270 A1	12-2003	Uemura, Toshiya	257/99
	C	US-2003/0094622 A1	05-2003	Horiuchi et al.	257/100
	D	US-2002/0070449 A1	06-2002	Yagi et al.	257/734
	E	US-2002/0070387 A1	06-2002	Wang et al.	257/98
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	D					
	R				,	
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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